

<b>Notice of References Cited</b>	Application/Control No. 10/519,322		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Sam K. Ahn		Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,678,336	01-2004	Katoh et al.	375/316
*	B	US-6,990,627	01-2006	Uesugi et al.	714/794
*	C	US-7,230,992	06-2007	Walker et al.	375/260
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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